

N-channel SiC power MOSFET

Datasheet

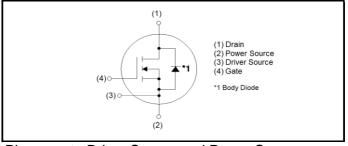
V _{DSS}	650V
R _{DS(on)} (Typ.)	80mΩ
I _D ^{*1}	30A
P_D	134W

Outline TO-247-4L (1) (2)(3)(4)

Features

- 1) Low on-resistance
- 2) Fast switching speed
- 3) Fast reverse recovery
- 4) Easy to parallel
- 5) Simple to drive
- 6) Pb-free lead plating; RoHS compliant

•Inner circuit



Please note Driver Source and Power Source are not exchangeable. Their exchange might lead to malfunction.

Application

- Solar inverters
- DC/DC converters
- Switch mode power supplies
- · Induction heating
- Motor drives

Packaging specifications

	Packing	Tube
	Reel size (mm)	-
Typo	Tape width (mm)	-
Type	Basic ordering unit (pcs)	30
	Taping code	C15
	Marking	SCT3080AR

● Absolute maximum ratings (T_{vj} = 25°C unless otherwise specified)

Parameter		Symbol	Value	Unit
Drain - Source Voltage		V_{DSS}	650	V
Continuous Drain current	$T_c = 25^{\circ}C$	I _D *1	30	А
Continuous Drain current	T _c = 100°C	I _D *1	21	А
Pulsed Drain current (T _c = 25°C)		I _{D,pulse} *2	75	А
Gate - Source voltage (DC)		V_{GSS}	-4 to +22	V
Gate - Source surge voltage (t _{surge} < 300ns)		$V_{\rm GSS_surge}^{*3}$	-4 to +26	V
Recommended drive voltage		V _{GS_op} *4	0 / +18	V
Virtual Junction temperature		T_{vj}	175	°C
Range of storage temperature		T _{stg}	-55 to +175	°C

●Electrical characteristics (T_{vj} = 25°C unless otherwise specified)

Darameter	Symbol	Conditions		Values		Linit
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
		$V_{GS} = 0V$, $I_D = 1mA$				
Drain - Source breakdown voltage	V _{(BR)DSS}	$T_{vj} = 25^{\circ}C$	650	-	-	V
vollago		T _{vj} = -55°C	650	-	-	
		$V_{GS} = 0V, V_{DS} = 650V$				
Zero Gate voltage Drain current	I _{DSS}	$T_{vj} = 25^{\circ}C$	-	1	10	μΑ
Diam current		T _{vj} = 150°C	-	2	-	
Gate - Source leakage current	I _{GSS+}	$V_{GS} = +22V, \ V_{DS} = 0V$	-	-	100	nA
Gate - Source leakage current	I _{GSS-}	$V_{GS} = -4V$, $V_{DS} = 0V$	-	-	-100	nA
Gate threshold voltage	V _{GS (th)}	$V_{DS} = 10V$, $I_D = 5mA$	2.7	-	5.6	V
		$V_{GS} = 18V, I_D = 10A$				
Static Drain - Source on - state resistance	R _{DS(on)} *5	$T_{vj} = 25^{\circ}C$	-	80	104	mΩ
on state resistance		T _{vj} = 150°C	-	115	-	
Gate input resistance	R_{G}	f = 1MHz, open drain	-	13	-	Ω

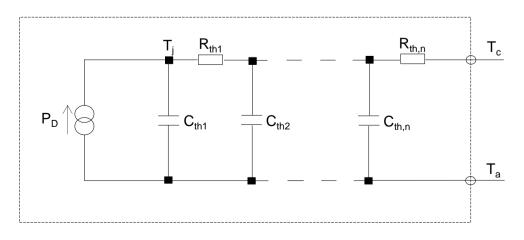
●Thermal resistance

Parameter	Symbol	Values			Unit
r al allielei		Min.	Тур.	Max.	Offic
Thermal resistance, junction - case	R_{thJC}	-	0.86	1.12	K/W

●Typical Transient Thermal Characteristics

Symbol	Value	Unit
R _{th1}	1.14×10 ⁻¹	
R _{th2}	5.07×10 ⁻¹	K/W
R _{th3}	2.51×10 ⁻¹	

Symbol	Value	Unit
C_{th1}	5.02×10 ⁻⁴	
C_{th2}	4.91×10 ⁻³	Ws/K
C _{th3}	4.99×10 ⁻²	



ullet Electrical characteristics (T_{vj} = 25°C unless otherwise specified)

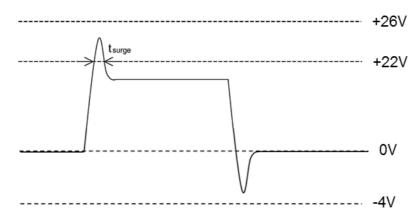
Parameter	Symbol Conditions	Values			Unit	
Parameter		Conditions	Min.	Тур.	Max.	Offic
Transconductance	g_{fs}^{*5}	$V_{DS} = 10V, I_{D} = 10A$	-	3.8	-	S
Input capacitance	C _{iss}	V _{GS} = 0V	-	571	-	
Output capacitance	C _{oss}	V _{DS} = 500V	1	39	-	pF
Reverse transfer capacitance	C_{rss}	f = 1MHz	-	19	-	
Effective output capacitance, energy related	C _{o(er)}	$V_{GS} = 0V$ $V_{DS} = 0V \text{ to } 300V$	ı	99	ı	pF
Total Gate charge	Q_g^{*5}	$V_{DS} = 300V$ $I_{D} = 10A$	ı	48	-	
Gate - Source charge	Q _{gs} *5	$V_{GS} = 18V$	ı	10	-	nC
Gate - Drain charge	Q _{gd} *5	See Fig. 1-1.	-	25	-	
Turn - on delay time	t _{d(on)} *5	$V_{DS} = 400V$ $I_{D} = 15A$	ı	4	-	
Rise time	t _r *5	$V_{GS} = 0V/+18V$	-	14	-	no
Turn - off delay time	t _{d(off)} *5	$R_G = 0\Omega, L = 750\mu H$ $L_{\sigma} = 50nH, C_{\sigma} = 10pF$	ı	15	-	ns
Fall time	t _f *5	See Fig. 2-1, 2-2, 2-3.	-	13	-	
Turn - on switching loss	E _{on} *5	E _{on} includes diode reverse recovery.	-	77	-	11.1
Turn - off switching loss	E _{off} *5		-	15	-	μJ

●Body diode electrical characteristics (Source-Drain) (T_{vj} = 25°C unless otherwise specified)

Parameter	Symbol	Conditions		Values	Unit	
raidilletei	Symbol	Coriditions	Min.	Тур.	Max.	Offic
Body diode continuous, forward current	I _S *1	T _c = 25°C	ı	1	30	Α
Body diode direct current, pulsed	I _{SM} *2	1 _c = 25 0	ı	ı	75	Α
Forward voltage	V _{SD} *5	$V_{GS} = 0V, I_{S} = 10A$	ı	3.2	ı	V
Reverse recovery time	t _{rr} *5	$I_F = 10A$ $V_R = 400V$	ı	18	ı	ns
Reverse recovery charge	Q _{rr} *5	di/dt = 2500A/µs	ı	254	ı	nC
Peak reverse recovery current	: I _{rrm} *5	$L_{\sigma} = 50$ nH, $C_{\sigma} = 10$ pF See Fig. 3-1, 3-2.	-	23	-	Α

^{*1} Limited by maximum T_{vj} and for Max. R_{thJC} .

*3 Example of acceptable V_{GS} waveform



Please note especially when using driver source that $V_{\text{GSS_surge}}$ must be in the range of absolute maximum rating.

*5 Pulsed

9.Nov.2022 - Rev.002

^{*2} PW \leq 10µs, Duty cycle \leq 1%

^{*4} Please be advised not to use SiC-MOSFETs with V_{GS} below 13V as doing so may cause thermal runaway.

Fig.1 Power Dissipation Derating Curve

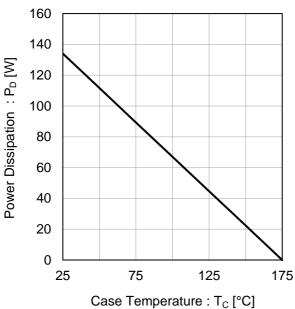


Fig.2 Maximum Safe Operating Area

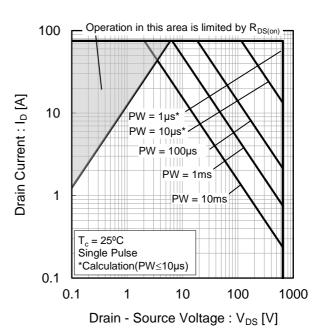
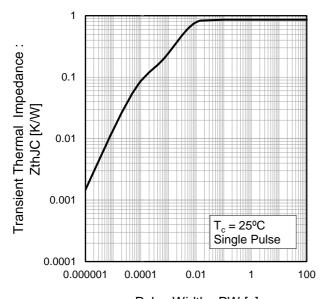


Fig.3 Typical Transient Thermal Impedance vs. Pulse Width



Pulse Width: PW [s]

Fig.4 Typical Output Characteristics(I)

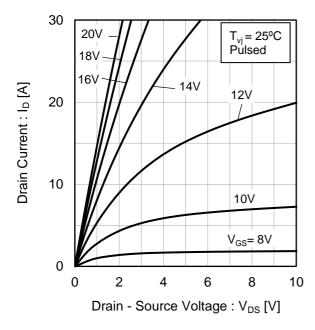


Fig.5 Typical Output Characteristics(II)

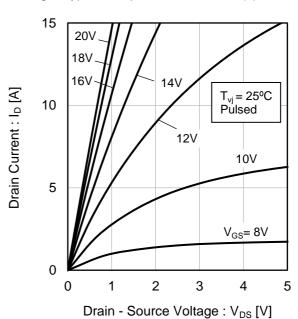
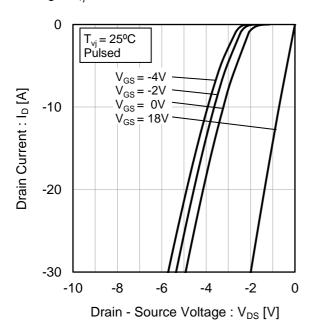
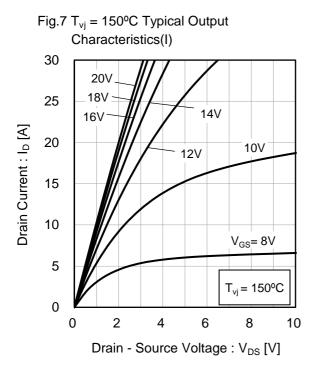


Fig.6 T_{vj} = 25°C 3rd Quadrant Characteristics





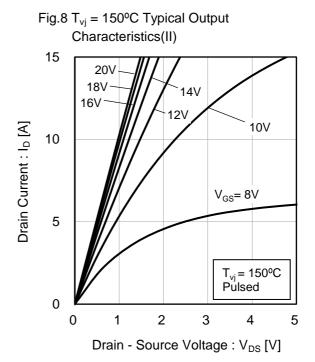


Fig.9 T_{vj} = 150°C 3rd Quadrant Characteristics

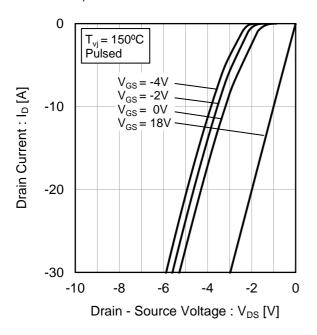


Fig.10 Body Diode Forward Voltage vs. Gate - Source Voltage

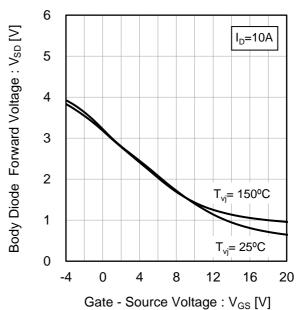


Fig.11 Typical Transfer Characteristics (I)

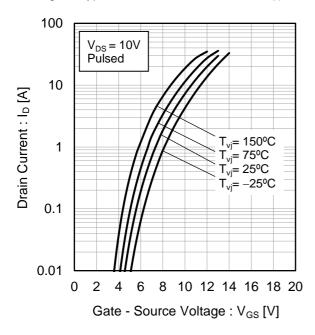


Fig.12 Typical Transfer Characteristics (II)

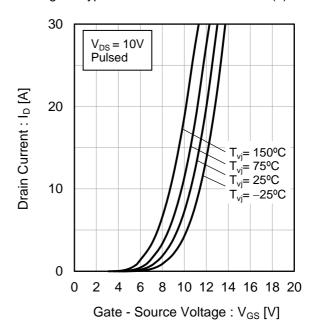


Fig.13 Gate Threshold Voltage vs. Virtual Junction Temperature

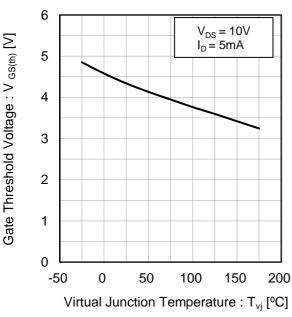
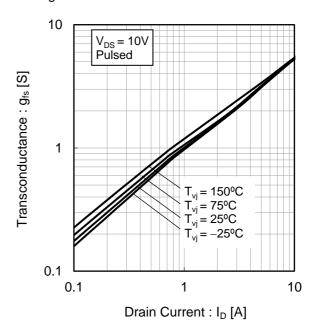


Fig.14 Transconductance vs. Drain Current



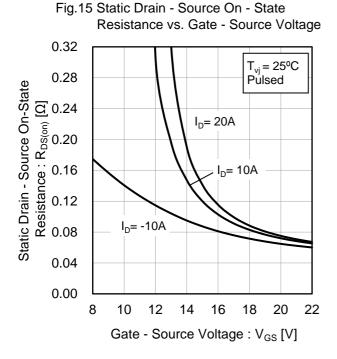


Fig.16 Static Drain - Source On - State Resistance vs. Virtual Junction Temperature 0.16 $V_{GS} = 18V$ Pulsed

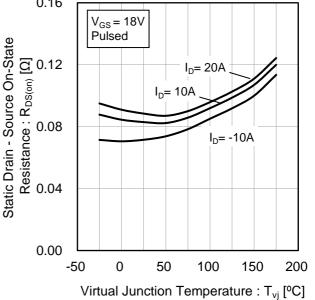


Fig.17 Static Drain - Source On - State Resistance vs. Drain Current Static Drain - Source On-State Resistance : $R_{DS(on)}\left[\Omega\right]$ 0.1 _{vj} = 150°C $T_{vj} = 125^{\circ}C$ $T_{vj} = 75^{\circ}C$ = 25°C -25°C $V_{GS} = 18V$ Pulsed 0.01 10 1 100 Drain Current: ID [A]

1.04 1.03 **Breakdown Voltage** 1.02 1.01 1.00 0.99 0.98

50

100

Virtual Junction Temperature : T_{vi} [°C]

150

200

0

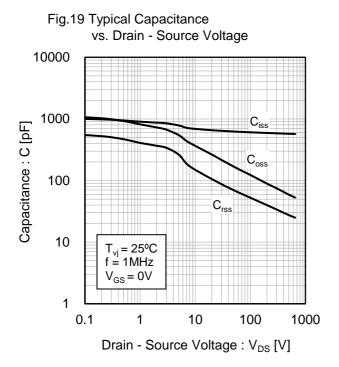
-50

Fig.18 Normalized Drain - Source Breakdown

Voltage vs. Virtual Junction Temperature

ROHM

Normalized Drain - Source



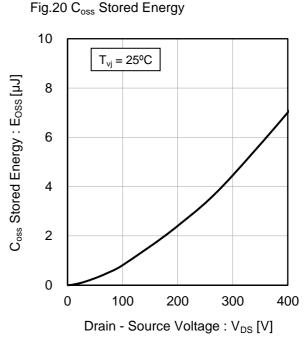
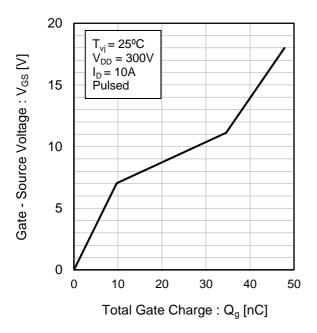


Fig.21 Dynamic Input Characteristics



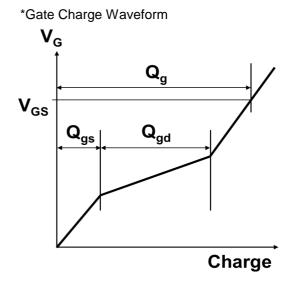


Fig.22 Typical Switching Time

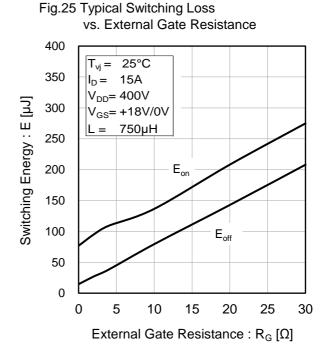
vs. External Gate Resistance 80 $T_{vi} = 25^{\circ}C$ $V_{DD} = 400V$ $V_{GS} = +18V/0V$ 60 Switching Time: t [ns] $I_D = 15A$ $L = 750 \mu H$ 40 20 $t_{d(on)}$ 0 10 20 30 0

External Gate Resistance : $R_G[\Omega]$

vs. Drain - Source Voltage 100 $T_{vj} = 25^{\circ}C$ $I_D = 15A$ V_{GS}= +18V/0V 80 Switching Energy: E [µJ] $R_G = 0\Omega$ $L = 750 \mu H$ E_{on} 60 40 20 E_{off} 0 100 200 300 400 500 Drain - Source Voltage: V_{DS} [V]

Fig.23 Typical Switching Loss

Fig.24 Typical Switching Loss vs. Drain Current 400 25°C $T_{vj} =$ 350 $V_{DD} = 400V$ $V_{GS} = +18V/0V$ Switching Energy: E [µJ] 300 $R_G = 0\Omega$ $L = 750 \mu H$ 250 200 150 100 E_{on} E_{off} 50 0 10 20 30 0 Drain Current: ID [A]



Measurement circuits and waveforms

Fig.1-1 Gate Charge Measurement Circuit

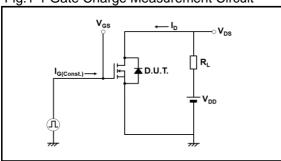


Fig.2-1 Switching Characteristics Measurement Circuit

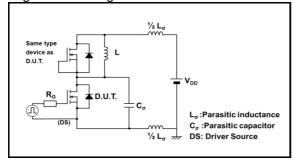


Fig.2-2 Waveforms for Switching Time

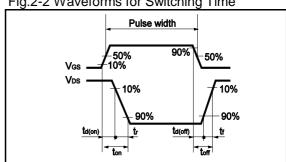


Fig.2-3 Waveforms for Switching Energy Loss

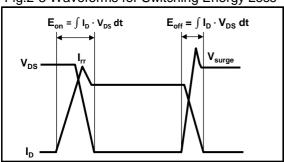


Fig.3-1 Reverse Recovery Time Measurement Circuit

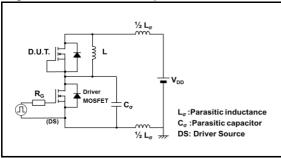
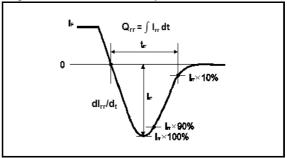
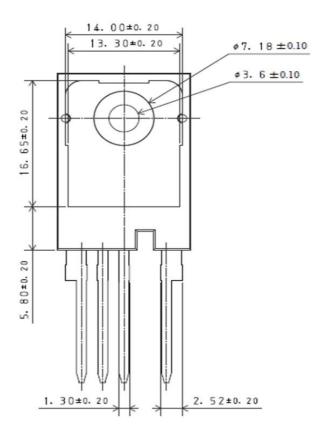


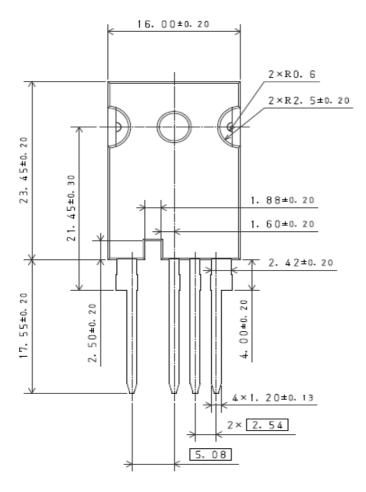
Fig.3-2 Reverse Recovery Waveform

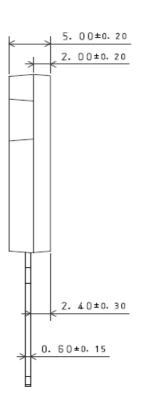




Unit: mm

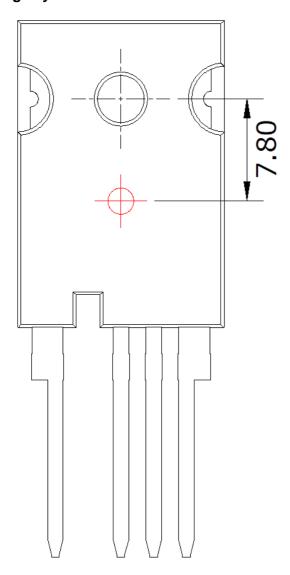
●Package Dimensions





Unit: mm

●Die Bonding Layout





- •Front view of the packaging.
- •Dimensions are design values.
- •If the heat sink is to be installed, it should be in contact with the die bonding point.

Unit: mm

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